

Search Notes

Application/Control No.

10/613,216

Examiner

Duc Nguyen

Applicant(s)/Patent under
Reexamination

TOYOSHIMA ET AL.

Art Unit

2643

SEARCHED

Class	Subclass	Date	Examiner
Updated	search	2/4/2006	DN
same	as		
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	searches		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR